

### High voltage fast-switching NPN power transistor

#### **Features**

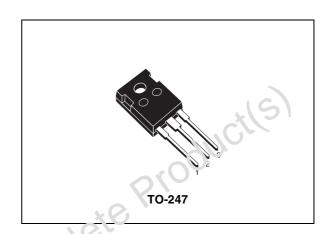
- High voltage capability
- Very high switching speed
- Minimum lot-to-lot spread for reliable operation
- Low base-drive requirements

#### **Applications**

- Switch mode power supplies
- Motor control



The BUF410A is manufactured using high voltage multi epitaxial planar technology for high switching speeds and high voltage capacity. It uses a cellular emitter structure with planar edge termination to enhance switching speeds while maintaining a wide RBSOA.



'-เงูนาย 1. Internal schematic diagram

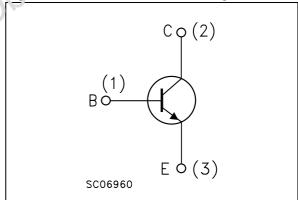


Table 1. Device summary

Order code	Marking	Package	Packaging		
BUF410A	BUF410A	TO-247	Tube		

Electrical ratings BUF410A

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>CEV</sub>	Collector-emitter voltage (V <sub>BE</sub> = -1.5 V)	1000	V
V <sub>CEO</sub>	Collector-emitter voltage (I <sub>B</sub> = 0)	450	V
V <sub>EBO</sub>	Emitter-base voltage $(I_C = 0)$	7	V
I <sub>C</sub>	Collector current	15	Α
I <sub>CM</sub>	Collector peak current (t <sub>P</sub> < 5 ms)	30	Α
Ι <sub>Β</sub>	Base current	3	Α
I <sub>BM</sub>	Base peak current (t <sub>P</sub> < 5 ms)	1.5	Α
P <sub>tot</sub>	Total dissipation at T <sub>c</sub> = 25 °C	125	W
T <sub>stg</sub>	Storage temperature	-65 to 150	°C
TJ	Max. operating junction temperature	150	°C

Table 3. Thermal data

	Symbol	Parameter		Value	Unit	
	R <sub>thj-case</sub>	Thermal resistance inclion-case	max	1	°C/W	
	,	CIC			•	
		1000				
	0					
	10'					
~O/k						
0/02						
0.						

### 2 Electrical characteristics

 $(T_{case} = 25 \, ^{\circ}C \text{ unless otherwise specified})$ 

Table 4. Electrical characteristics

	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	I <sub>CER</sub>	Collector cut-off current (R <sub>BE</sub> = 10 Ω)	V <sub>CE</sub> = 1000 V V <sub>CE</sub> = 1000 V T <sub>C</sub> = 100 °C			0.2	mA mA
	I <sub>CEV</sub>	Collector cut-off current (V <sub>BE</sub> = -1.5 V)	V <sub>CE</sub> = 1000 V V <sub>CE</sub> = 1000 V T <sub>C</sub> = 100 °C			0.2	Anr Anr
	I <sub>EBO</sub>	Emitter cut-off current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 5 V	00	M	1	mA
	V <sub>CEO(sus)</sub> (1)	Collector-emitter sustaining voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = 200 mA	450			V
	V <sub>EBO</sub>	Emitter-base voltage (I <sub>C</sub> = 0)	I <sub>E</sub> = 50 mA	7			V
	V <sub>CE(sat)</sub> (1)	Collector-emitter saturation voltage	$I_C = 5 \text{ A}$ $I_B = 0.5 \text{ A}$ $I_C = 5 \text{ A}$ $I_B = 0.5 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$ $I_C = 10 \text{ A}$ $I_B = 2 \text{ A}$ $I_C = 10 \text{ A}$ $I_B = 2 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$		0.8	2.8	< < < <
	V <sub>BE(85.1)</sub> (1)	Basc-emitter	$I_C = 5 \text{ A}$ $I_B = 0.5 \text{ A}$ $I_C = 5 \text{ A}$ $I_B = 0.5 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$ $I_C = 10 \text{ A}$ $I_B = 2 \text{ A}$ $I_C = 10 \text{ A}$ $I_B = 2 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$		0.9	1.5	V V V
Obsole	di <sub>c /</sub> dt	Rate of rise on-state collector current	$\begin{split} & V_{CC} = 300 \ V & R_C = 0 & t_p = 3 \ \mu s \\ & I_{B1} = 0.75 \ A & T_C = 25 \ ^{\circ}C \\ & I_{B1} = 0.75 \ A & T_C = 100 \ ^{\circ}C \\ & I_{B1} = 3 \ A & T_C = 100 \ ^{\circ}C \end{split}$	45 100	60		A/μs A/μs A/μs
	V <sub>CE(dyn)</sub>	Collector-emitter dynamic voltage (3 µs)	$V_{CC} = 300 \text{ V}$ $R_C = 60 \Omega$ $I_{B1} = 0.75 \text{ A}$ $T_C = 25 ^{\circ}\text{C}$ $I_{B1} = 0.75 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$		2.1	8	V V
	V <sub>CE(dyn)</sub>	Collector-emitter dynamic voltage (5 µs)	$V_{CC} = 300 \text{ V}$ $R_C = 60 \Omega$ $I_{B1} = 0.75 \text{ A}$ $T_C = 25 ^{\circ}\text{C}$ $I_{B1} = 0.75 \text{ A}$ $T_C = 100 ^{\circ}\text{C}$		1.1	4	V V
	t <sub>s</sub> t <sub>f</sub> t <sub>C</sub>	Inductive load Storage time Fall time Cross over time	$\begin{split} I_{C} &= 5 \text{ A} & V_{CC} &= 50 \text{ V} \\ V_{BB} &= -5 \text{ V} & R_{BB} &= 1.2 \Omega \\ V_{Clamp} &= 400 \text{ V} & I_{B1} &= 0.5 \text{ A} \\ L &= 0.5 \text{ mH} \end{split}$		0.8 0.05 0.08		μs μs μs

57

Electrical characteristics BUF410A

Table 4. Electrical characteristics (continued)

	Symbol	Parameter	Test co	nditions	Min.	Тур.	Max.	Unit
	t <sub>s</sub> t <sub>f</sub>	Inductive load Storage time Fall time Cross over time	$I_{C} = 5 A$ $V_{BB} = -5 V$ $V_{Clamp} = 400 V$ $L = 0.5 \text{ mH}$				1.8 0.1 0.18	μs μs μs
	V <sub>CEW</sub>	Maximum collector emitter voltage without snubber	$I_C = 5 A$ $V_{BB} = -5 V$ $I_{B1} = 0.5 A$ $T_C = 125 °C$		500			V
	t <sub>s</sub> t <sub>f</sub> t <sub>c</sub>	Inductive load Storage time Fall time Cross over time	$I_{C} = 5 \text{ A}$ $V_{BB} = 0$ $V_{Clamp} = 400 \text{ V}$ $L = 0.5 \text{ mH}$	$V_{CC} = 50 \text{ V}$ $R_{BB} = 0.3 \Omega$ $I_{B1} = 0.5 \text{ A}$	C	1.5 7.04 0.07	ile	μs μs μs
	t <sub>s</sub> t <sub>f</sub> t <sub>c</sub>	Inductive load Storage time Fall time Cross over time	$I_{C} = 5 \text{ A}$ $V_{BB} = 0$ $V_{Clamp} = 400 \text{ V}$ $L = 0.5 \text{ mH}$	$V_{CC} = 50 \text{ V}$ $R_{BB} = 0.0 \Omega$ $I_{E1} = 0.5 \text{ A}$ $I_{C} = 100 \text{ °C}$			3 0.15 0.25	μs μs μs
	V <sub>CEW</sub>	Maximum collector emitter voltage without snubber	$I_{C} = 5 \text{ A}$ $V_{BL} = 0$ $I_{B1} = 0.5 \text{ A}$ $I_{C} = 125 \text{ °C}$	$V_{CC}$ = 50 V $R_{BB}$ = 0.3 $\Omega$ L = 0.5 mH	500			V
	t <sub>S</sub> t <sub>f</sub>	Inductive oad Storago fime Fall time Cross over time	$I_{C} = 10 \text{ A}$ $V_{BB} = -5 \text{ V}$ $V_{Clamp} = 400 \text{ V}$ $L = 0.25 \text{ mH}$			1.9 0.06 0.12		μs μs μs
insole	t <sub>s</sub> t <sub>f</sub> t <sub>c</sub>	Inductive load Storage time Fall time Cross over time	$I_C = 10 \text{ A}$ $V_{BB} = -5 \text{ V}$ $V_{Clamp} = 400 \text{ V}$ $L = 0.25 \text{ mH}$				3.2 0.12 0.3	μs μs μs
) ~	V <sub>CEW</sub>	Maximum collector emitter voltage without snubber	$I_C = 15 \text{ A}$ $V_{BB} = -5 \text{ V}$ $I_{B1} = 3 \text{ A}$ $T_C = 125 \text{ °C}$	$V_{CC} = 50 \text{ V}$ $R_{BB} = 1.2 \Omega$ $L = 0.1 \text{ mH}$	400			V

<sup>1.</sup> Pulse duration = 300  $\mu$ s, duty cycle  $\leq$  1.5%

4/9

### 2.1 Electrical characteristics (curves)

Figure 2. Forward biased safe operating area

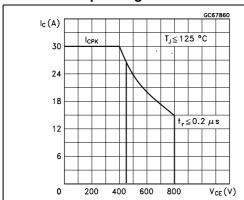
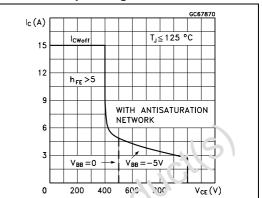
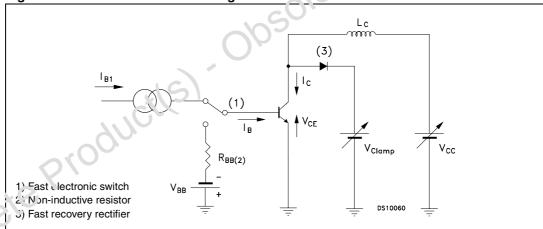


Figure 3. Reverse biased safe operating area



#### 2.2 Test circuit

Figure 4. Inductive load switching test circuit



**47/** 

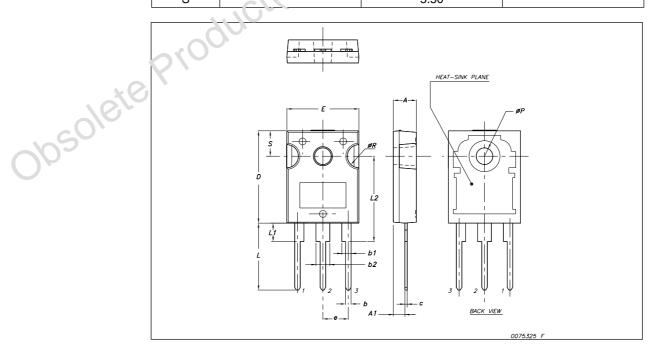
### 3 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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#### **TO-247 Mechanical data**

Dim.	mm.					
Diiii.	Min.	Тур	Max.			
Α	4.85		5.15			
A1	2.20		2.60			
b	1.0		1.40			
b1	2.0		2.40			
b2	3.0		3.40			
С	0.40		0.80			
D	19.85		20.15			
E	15.45	20,	15.75			
е		5/5				
L	14.20	60/0	14.80			
L1	3.70	102	4.30			
L2		18.50				
øΡ	3.55		3.65			
øR	4.50		5.50			
S		5.50				



**577** 

Revision history BUF410A

## 4 Revision history

Table 5. Document revision history

Date	Revision	Changes
18-Mar-2002	2	
13-Mar-2008	3	Package change from TO-218 to TO-247.

Obsolete Product(s). Obsolete Product(s)

8/9

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